

Notice of References CitedApplication/Control No.
09/891,569Applicant(s)/Patent Under
Reexamination
WENZEL ET AL.Examiner
Virginia M KiblerArt Unit
2623

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,615,158	09-2003	Wenzel et al.	702/183
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	R					
	S					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Nair et al., "Image Processing and Low Discrepancy Sequences," SPIE Conference on Advanced Signal Processing Algorithms, Architectures, and Implementations IX, July 1999, pages 102-111.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.